



Dual N-Channel 30 V (D-S) MOSFET

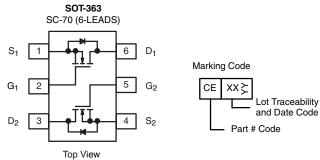
PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
30	0.190 at V _{GS} = 10 V	1.3	0.91 nC		
30	0.344 at V _{GS} = 4.5 V	1.3	0.91110		

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_q Tested
- Compliant to RoHS Directive 2002/95/EC



HALOGEN FREE

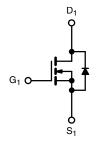


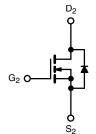
Ordering Information:

Si1972DH-T1-E3 (Lead (Pb)-free) Si1972DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

Load Switch for Portable Applications





N-Channel MOSFET

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		1.3 ^a		
Continuous Drain Current /T = 150 °C\	T _C = 70 °C		1.3 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	1.3 ^a		
	T _A = 70 °C		1.2	A	
Pulsed Drain Current		I _{DM}	4		
Continuous Source-Drain Diode Current	T _C = 25 °C	1	1		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.61 ^c		
	T _C = 25 °C		1.25		
Maximum Bayer Dissination	T _C = 70 °C	В	0.8	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	0.74 ^{b, c}	VV	
	T _A = 70 °C		0.47 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	130	170	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	80	100		

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 220 °C/W.

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SPECIFICATIONS (T _J = 25 °C, unless otherwise noted) Parameter Symbol Test Conditions Min. Typ. Max. Unit								
Static	Syllibol	rest conditions	IVIIII.	Typ.	IVIAX.	Oilit		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V		
V _{DS} Temperature Coefficient	V_{DS} $V_{GS} = 0$ V, $V_{DS} = 250$ μ A V_{DS}/T_J		- 30	23.5				
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		- 4.6		mV/°C		
Gate-Source Threshold Voltage		$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1.5	- 4.0	2.8	V		
Gate-Source Leakage	V _{GS(th)}	V _{DS} = 0 V, V _{GS} = ± 20 V	1.5		± 100			
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	ns		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μΑ		
On-State Drain Current ^a	ls()	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, V_{J} = 55 \text{ C}$ $V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	4		10	Α		
Cit State Brain Surrent				0.155	0.225			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 1.3 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 0.29 \text{ A}$		0.133	0.223	Ω		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 1.3 \text{ A}$		1.4	0.540	S		
Dynamic ^b	9fS	VDS = 10 V, 1D = 1.0 A		1.4				
Input Capacitance	C _{iss}			75	<u> </u>	<u> </u>		
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		18		pF		
Reverse Transfer Capacitance	C _{rss}	VDS = 10 V, VGS = 0 V, 1 = 1 1011 12		6				
Tieverse mansier expandance	rss	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 1.3 A		1.85	2.8	nC		
Total Gate Charge	Q_g	VDS = 13 V, VGS = 10 V, ID = 1.3 A		0.91	1.4			
Gate-Source Charge	Q _{gs}	V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 1.3 A		0.51				
Gate-Drain Charge	Q _{gd}	go do p		0.3				
Gate Resistance	R _g	f = 1 MHz	0.9	4.5	9	Ω		
Turn-On Delay Time	t _{d(on)}			15	25	ns		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 12.5 \Omega$		50	75			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.2 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		7	15			
Fall Time	t _f			15	25			
Turn-on Delay Time	t _{d(on)}			5	10			
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 12.5 \Omega$		10	15			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.2 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		10	15			
Fall Time	t _r			6	12			
Drain-Source Body Diode Characteristic	cs	<u> </u>			L			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			1	А		
Pulse Diode Forward Current	I _{SM}	-			4			
Body Diode Voltage	V _{SD}	I _S = 1.2 A, V _{GS} = 0 V		0.85	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			18	36	nC		
Reverse Recovery Fall Time	t _a	$I_F = 1.2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		16				
Reverse Recovery Rise Time	t _b	\dashv		4		ns		

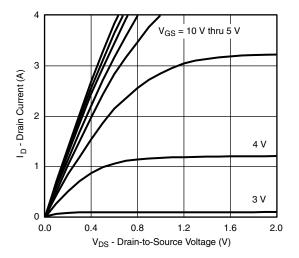
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

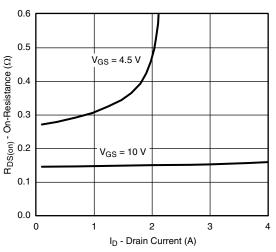
b. Guaranteed by design, not subject to production testing.



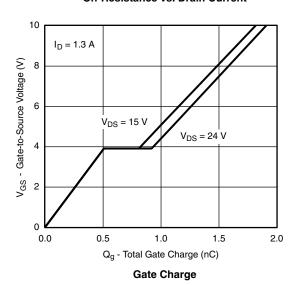
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



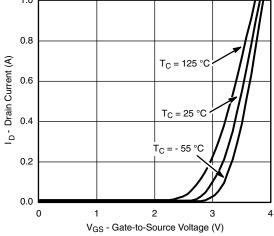
Output Characteristics



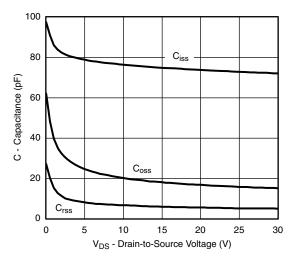
On-Resistance vs. Drain Current



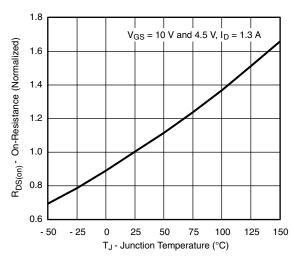
1.0



Transfer Characteristics



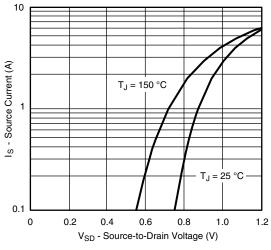
Capacitance

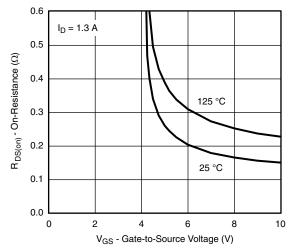


On-Resistance vs. Junction Temperature

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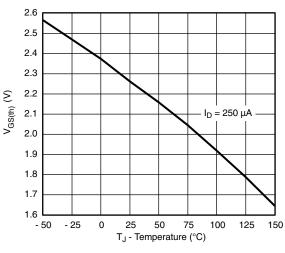
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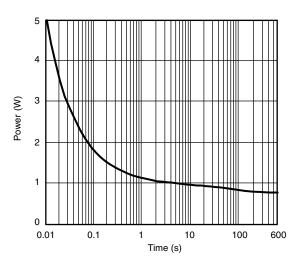




Forward Diode Voltage

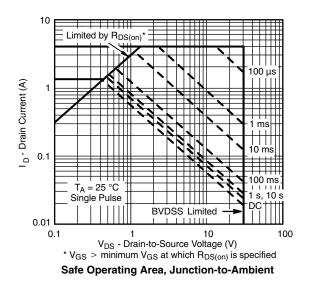
On-Resistance vs. Gate-Source Voltage





Threshold Voltage

Single Pulse Power

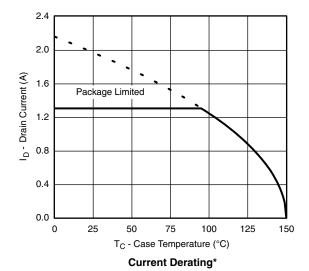


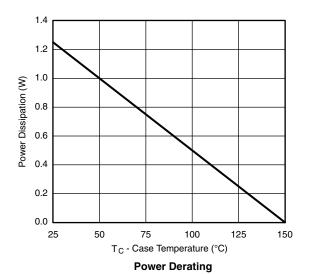






TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



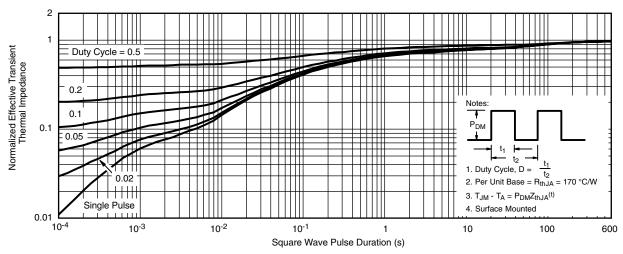


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

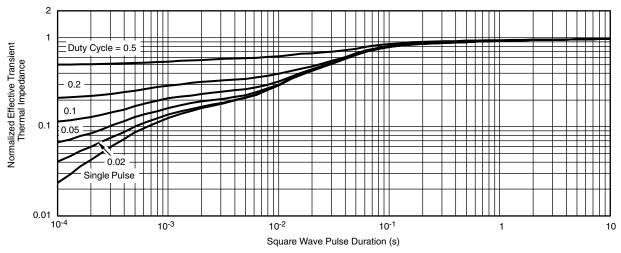
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TYPICAL CHARACTERISTICS (25 °C, unless otherwiese noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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